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Article

Integrated Circuits from Lighting Equipment: Presence and Characterisation of Precious Metals (Ag, Au, Pd, Pt)

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Abstract

To reduce energy consumption in buildings and maintain comfortable conditions, lighting equipment that includes light-emitting diode (LED) lamps and lighting management equipment is utilised. In this study, integrated circuits detached from lighting equipment were characterised for the presence of precious metals (silver, gold, palladium, and platinum). Their digestion was carried out with HNO₃ and aqua regia solution on a hot plate and characterised using inductively coupled plasma optical emission spectroscopy (ICP-OES). The concentration of each element as a function of the type and origin of the integrated circuits varied as follows: silver, 652–3876 mg/kg; gold, 0–993 mg/kg; palladium, 0–74 mg/kg; and platinum was detected at a concentration below the quantification limit. These results indicate the need for selective removal and separate recycling processes for integrated circuits from the lighting equipment.

Keywords: LED lamps; lighting management equipment; driver; integrated circuits; precious metals; ICP-OES analysis

1. Introduction

Generally, preserving life is inextricably linked to energy consumption. However, preserving the quality of life requires proper energy management, as energy production and conversion have a significant impact on the environment. Therefore, transitioning from reckless to rational energy use is essential for preserving natural resources and the quality of life on our planet. Depending on the age and construction specifications of buildings, as well as environmental conditions, a significant portion of the available energy is spent on achieving and maintaining internal comfortable conditions [1].

Various strategies are selected on a case-by-case basis to reduce energy consumption while maintaining comfortable conditions. These include 'passive' strategies, such as daylighting and solar shading, as well as 'active' strategies, including more efficient lighting technologies. Lighting equipment (LE), which forms part of a building's electrical installation and may include light-emitting diode (LED) lamps and lighting management equipment (LME), also contributes to achieving the above objectives [2]. LE contributes to energy savings in buildings by synergising various parameters

in each application. In the case of LED lamps, this is achieved through their combination of high energy efficiency and low heat emission. In the case of LME, it is achieved by monitoring environmental conditions and human presence.

Electrical and electronic equipment (EEE) is classified as waste electrical and electronic equipment (WEEE) when it reaches the end of its functional life. LED lamps fall under 'CAT 3' of WEEE by Directive 2012/19 of the European Union (EU), and LME under 'CAT 5' [3].

1.1. WEEE Recycling

Many chemical elements in WEEE are an important technological parameter that distinguishes urban mining from natural mining [4]. As a result, WEEE recycling has not been standardised [5]. The presence of valuable and precious metals in EEE [6] makes WEEE a special and interesting waste category with significant and dynamic economic value. During WEEE recycling, particularly during pre-treatment, separating them according to the presence and concentrations of these metals contributes to their optimal recovery [7], consequently increasing the protection of natural reserves [8] and offsetting the operating costs of recovering low-value critical raw materials [7]. It is worth noting that recovering these metals from urban mines requires significantly less energy (85–90%) than natural mining [7], leading to increased environmental protection.

Identifying and quantifying precious metals (PMs) in WEEE is critical in the recycling sector [9]. This information is utilised in the pre-treatment of this type of waste [10] and aids in creating recycling streams with high concentrations of these metals [11]. These metals are typically present in the electrical contacts and interconnections of the individual components and structures of EEE [12], with the elemental composition of these points varying significantly depending on the economic and technical parameters [13, 14] of each application. The potential synergy between economic and technical parameters, such as the annual increase in WEEE [15], targeted recycling, dynamic metal prices and energy gains associated with urban mining [7], is expected to offset the gradual decrease in the presence of precious metals in EEE [16, 17] and maintain high interest in recovering these metals from urban mines [18].

When dismantling WEEE, the typical fractions obtained depend on the type of equipment and correspond to basic materials, such as metals, plastics, glass, and ceramics, as well as specific sub-structures, including screens, LED modules, and drivers. It should be noted that the percentage of each sub-structure [19, 20] and its elemental composition [21] vary significantly depending on the type, electrical characteristics and specifications of the equipment.

1.2. Driver

The driver typically constitutes 4–7 wt% of the equipment's total mass [22] and facilitates the two-way 'coupling' between software and hardware [23], ensuring the equipment operates smoothly and safely. In general, a driver consists of electrical and electronic components (EECs), electrical insulation materials (EIMs), and printed circuit board (PCB) (Figure 1a). Depending on the type of equipment and its electrical characteristics, it may also include structures for managing the heat generated during operation, such as heatsinks (Figure 1b).

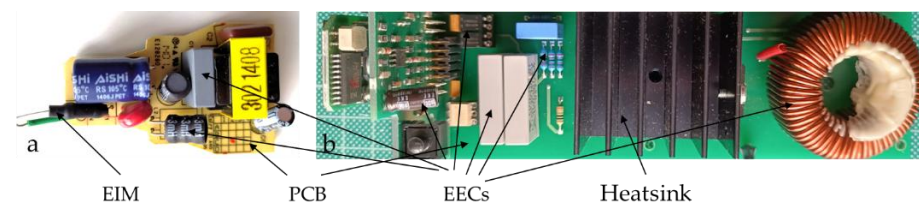


Figure 1. Indicative driver structures: a) LED lamp driver, b) LME driver (authors' images).

1.2.2. Valuable and Precious Metals in Drivers

The presence of valuable and precious metals in drivers [24–26] makes them valuable components of WEEE [27, 28], given that approximately 40% of the value recovered from WEEE recycling is due to these metals [26]. According to Hadi et al. (2015), recovering these metals from

drivers is considered more advantageous than primary extraction, both economically and environmentally [29].

The elemental composition and concentrations of drivers vary significantly depending on the type and specifications of the equipment, as well as the design technology and environmental requirements in force at the time of manufacture. According to Andooz et al. (2022), knowledge of the elemental composition of drivers is crucial for their separate sorting during the pre-treatment phase of WEEE, thereby contributing to the more effective and environment-friendly design of their recycling streams [11]. However, it is worth noting that according to Anshu Priya and Hait (2018), there is currently no detailed or complete information available on driver characterisation. This results in the loss of specific metals during drivers' recycling, particularly in cases where these metals are present in low concentrations [30].

1.2.3. Drivers' Recycling

During the pre-treatment phase of WEEE, drivers are removed from the equipment for separate, specialised recycling [31, 32] using a combination of physical and chemical methods [33]. The removal and dismantling of drivers contribute to preserving the stored potential of their metals [34], particularly by avoiding the airborne and non-airborne losses generated during the shredding of WEEE [35]. The complex structure of the drivers makes standardising a recycling process, particularly in the event of their recycling as a single structure, difficult; therefore, automatic or manual dismantling [36] and separating their components are standard practices [37]. Driver ECs can be classified according to: a) their operating principle (active, passive or electromechanical) [38]; b) macroscopic criteria (type, colour, and geometric dimensions) [39]; and c) the concentrations of precious metals [40], especially Au, since it accounts for approximately 80% of the total recovered value from drivers [38].

In targeted recycling, characterising EECs in terms of the concentrations of specific chemical elements in their structure is considered an essential process. The results will be used to optimise their recycling flows [27, 41, 42]. According to Maurice et al. (2021), targeted recycling of ECs may raise expectations for the recovery of high-value metals that are less common and found in lower concentrations in EECs than in commonly used precious metals (Ag, Au, Pd and Pt) [43]. It is worth noting that combining the functional assessment of electrical and electronic components [44] and their potential reuse [34] will contribute more to environmental, human, and natural resource protection [37] than recovering the stored potential of valuable and critical raw materials from these [45–47].

1.3. Integrated Circuits

Integrated circuits (ICs) belong to the "active" and "precious" categories of driver components. ICs are of particular interest from technological and recycling perspectives due to their utilisation of microelectronics and nanotechnology [48], as well as the significant concentrations of precious metals in their structure [49–53]. Precious metals are used in IC structures as contact or plating materials [36] due to their high conductivity and chemical stability, which contributes to the creation of durable and therefore reliable ICs [54].

Integrated circuits mainly consist of a microelectronic structure (die or chip), a housing and internal conductive interconnections [55]. Electronic packaging typically involves integrating a microelectronic structure into a specialised housing to protect it from environmental conditions, and establishing conductive connections (wire) between the die's contacts (pads) and the housing's pins (lead frame) to supply power to the structure and enable communication with the physical world [56].

Literature Review

The literature review identified 50 studies on the characterisation of EECs in terms of the presence and concentrations of PMs in their structure. Specifically: Four for resistors [39, 50–52]; three for inductors [40, 51, 57]; three for diodes [39, 51, 58]; two for transistors [40, 51]; three for capacitors [40, 52, 59]; and three for varistors and ceramic capacitors [49, 50, 52]. Ten studies concerned tantalum

capacitors [8, 40, 51, 52, 60–65], 14 concerned multi-layer ceramic capacitors [19, 39, 40, 47, 49, 52, 66–73], and eight studies concerned integrated circuits, which are listed below.

Before presenting these studies, it is worth noting that despite the widespread use of ICs in EEE drivers and the expected increase in demand resulting from the development of artificial intelligence [15], the presence of precious metals in their structure [74] and their high degree of recoverability [75], the number of studies presenting data on precious metal concentrations in ICs is relatively small. This finding is confirmed by Li et al. (2019) [74] and Liu Xia et al. (2024) [71].

Delfini et al. (2011) studied the drivers of personal computers, monitors and TVs. Among other results, they present the characterisation results of the ICs from these three cases, particularly about PMs (Au, Pd) [49]. Lee et al. (2011) studied 22 different types of integrated circuits derived from scrap ICs of an unknown origin. Among other data, they provided results characterising the ICs in terms of the presence and concentrations of silver (Ag) and gold (Au) [74]. Jung et al. (2017) studied EECs derived from waste PCBs of the memory type. Among their results, they present the characterisation of ICs, particularly PMs (Ag, Au) [50]. Among the results of their study of the ICs, Liu et al. (2018) report that Ag is involved in the primary synthesis of the ICs [55]. (Li et al., 2019) Also, confirm the involvement of Ag in the main synthesis of ICs from computers [76]. Monneron-Enaud et al. (2020) studied the electronic components of medical equipment. Among their findings, they present the characterisation of ICs according to their surface area (i.e. small or large ICs), with a particular focus on PMs (Ag, Pd) [39]. Among other ECs, Panda et al. (2021) studied ICs from personal computers. They presented characterisation results corresponding to the naturally enriched sample of ICs (the metal fraction of ICs), particularly about Ag, Au, Pd and Pt [53]. Liu Xia et al. (2024) studied waste ICs that were removed from waste PCBs using an automated process. Among their characterisation results concerning the main composition of the ICs, they present data on Ag and Au [15].

The novelty of this study concerns the collection of waste ICs from lighting equipment (LED lamps and LME), separating according to their origin and placement (through-hole or surface mount) on the aforementioned equipment's PCBs, and characterising them in terms of the presence and concentrations of the elements Ag, Au, Pd, and Pt.

2. Results and Discussion

2.1. Separation and Participation of LE

Figure 2 shows the mass percentage of lamps of each base type found in the random sample examined in this study. The percentage ranged from 1.69 to 61.35 wt%, with MR16 lamps having the lowest representation and E27 lamps having the highest.

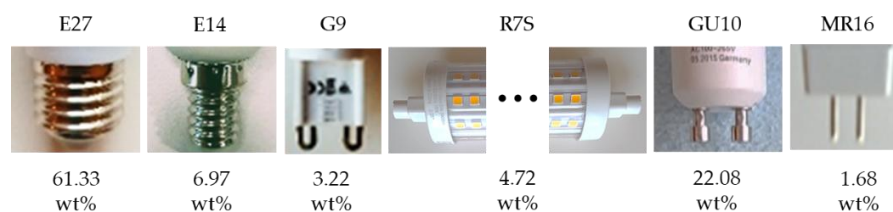


Figure 2. The basic types of lamp bases used for residential lighting (authors' images).

Additionally, the addition of the indicator (C) "classic" or (R) "retro" to the lamp base type denotes lamps with surface mount (SM) or filament LEDs, respectively. Figure 3 shows the mass percentage of each lamp type, based on its base and LED technology (surface mount or filament), about the mass of the random sample in this study. The percentage ranged from 1.09 to 53.59 wt%, with E14 lamps with filament LEDs having the lowest participation and E27 lamps with surface mount LEDs (SM-LEDs) having the highest.

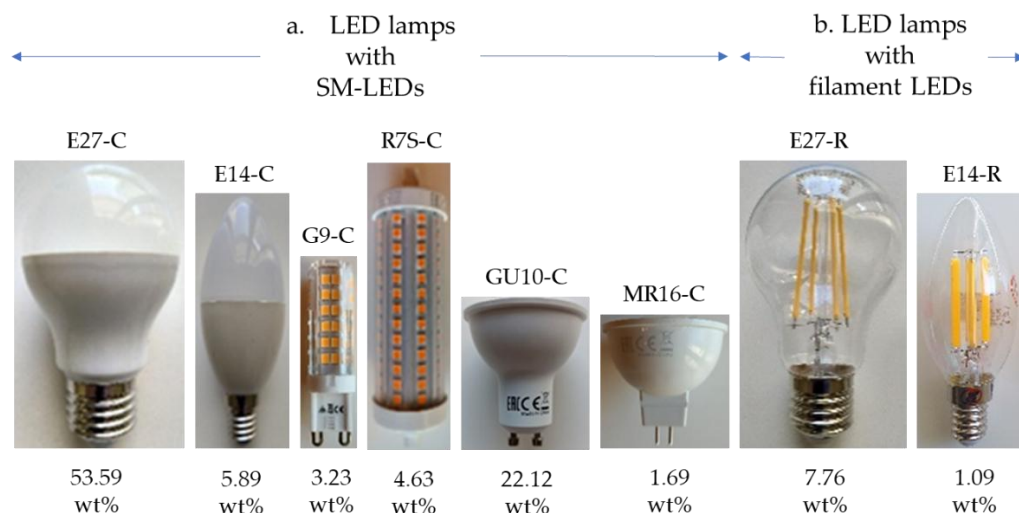


Figure 3. Classification of the main types of lamps used for residential lighting, based on their base and LED technology (authors' images).

In the random sample of this study, the percentage (%) of numerical participation of lamps depending on the type of base shows a tiny absolute difference compared to the corresponding average percentage obtained from the studies by Mizanur Rahman et al. (2019) [77], Benmamas et al. (2022) [78] and Wehbie & Semetey (2022) [79]: E27 (0.25%), E14 (3.48%), R7S (0.72%), GU10 (7.72%) and MR16 (3.53%). The most commonly used lamp types (E27, E14 and GU10) accounted for 84.02% of the present study sample, which is comparable to the 93.35% reported by Mizanur Rahman et al. (2019) [77]. Notably, lamps with a 'bayonet' B22 base type were only reported in the study by Benmamas et al. (2022) [78], while the G9 type was only present in the present study. According to Wehbie and Semetey (2022), the presence and percentage of each lamp type in a random sample depends on geographical area, climatic conditions, and the specific knowledge and culture of the population [79].

Depending on how the LME is installed in buildings, it is divided into two groups, LME-A and LME-B. Adding the indicator (A) or (B) to the abbreviation 'LME' indicates whether the equipment is installed: in an electrical panel (A), an electrical box or mounted on a wall (B). Figure 4 indicates these cases and their percentage of the total mass of the equipment examined in this study, highlighting the predominance of LME-A (77.34 wt%) over LME-B.

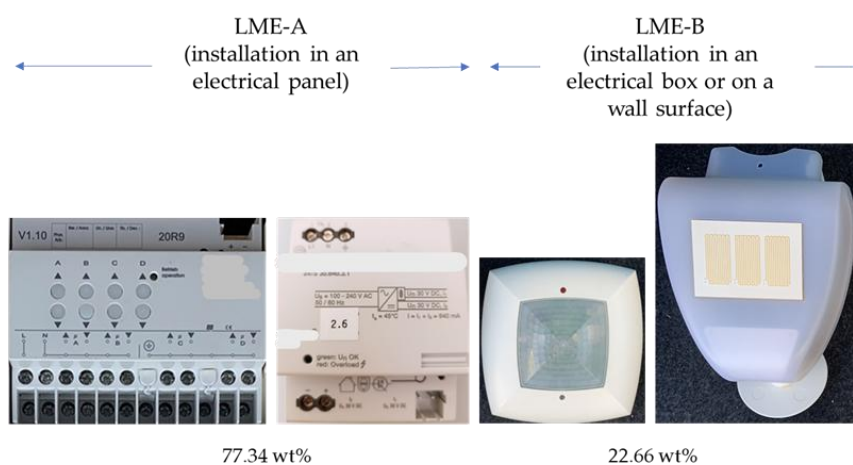


Figure 4. The LME separation depends on how it is installed in buildings (authors' images).

2.2. Selection of Lighting Equipment with Unique Technical Features

To investigate the masses of individual lighting equipment, particularly the presence of integrated circuits in its structure, equipment unique in terms of its technical characteristics or brand name was selected from the initial random sample for investigation.

Specifically, the lamps were selected based on their base type, electrical power, luminous flux, LED technology and brand name. Figure 5a shows the variation in the electrical power of the lamps, and Figure 5b shows the variation in their luminous flux. Based on the above parameters, the final configuration of the sample of lamps to be tested was as follows: E27-C (59 pieces/28 brands), E14-C (23 pieces/6 brands), G9-C (7 pieces/4 brands), R7S-C (3 pieces/2 brands), GU10-C (24 pieces/14 brands), MR16-C (5 pieces/2 brands), E27-R (11 pieces/7 brands) and E14-R (8 pieces/3 brands).

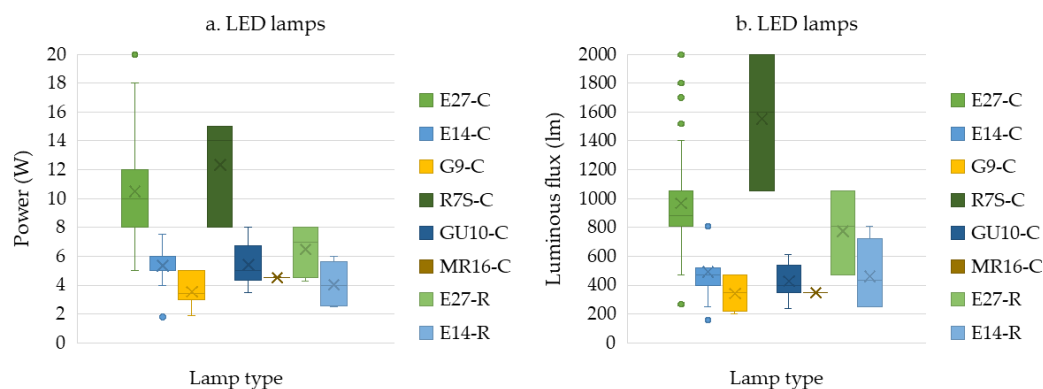


Figure 5. Variation in the electrical and photometric characteristics of the tested lamps.

The selection of LME units with unique technical characteristics was based on the type of equipment, its electrical power and its location within the electrical installations of the buildings. The composition of the LME sample under consideration was determined by the above parameters as follows: a) LME-A (9 units), including a switching actuator, dimmers, a motor control relay and a power supply; and b) LME-B (6 units), including a presence detector, a weather station, an information control unit, a push button, a bus coupler and a room temperature controller.

As shown in Figure 6, the mass of LE varies significantly depending on its type and technology. Specifically, Figure 6a illustrates the variation in mass of Edison-type lamps, highlighting the significant difference in mass depending on the LED technology used. Figure 6b illustrates the variation in mass among other lamps with the same LED technology, which also varies significantly depending on the lamp's type and specifications. Figure 6c illustrates the mass difference between LME-A and LME-B, highlighting the significant variation in mass depending on the type of equipment.

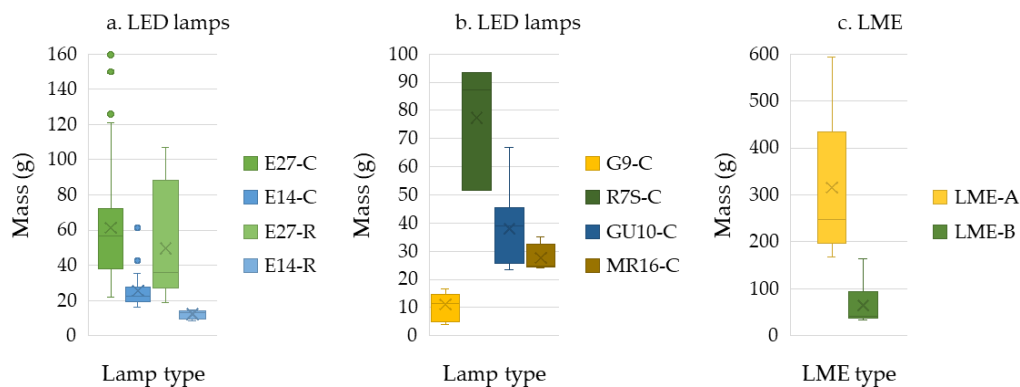


Figure 6. The variation in the mass of the lighting equipment was tested.

2.3. Individual Structures of LE

During the dismantling of the equipment, three categories of fractions were created. The first category, or 'basic', includes structures and components that are separated based on their raw

material, such as metal, plastic, glass and ceramic. The second category, or 'occasional', corresponds to other materials (OMs), such as sealant, welding silicone, and driver encapsulation material. The third category, or 'special', comprises special components, such as the LED module of non-retro-style lamps, the filament LED of retro-style lamps, and the driver commonly found in all types of lighting equipment examined in this study.

The variation in the percentage of materials and structures included in the first and third fraction categories, and in cases where these were part of the equipment structure, was as follows: Metals: (2.34–55.77) wt%, plastics (1.59–74.09) wt%, glass (50.14–97.33) wt%, ceramics (15.82–64.14) wt%, LED module (1.23–18.13) wt%, filament LEDs (0.81–9.96) wt%, and driver (1.16–80.39) wt%. It should be clarified that the basic metals of the equipment's special components (Figure 7) are expected to constitute a secondary basic metal fraction during their specialised recycling.

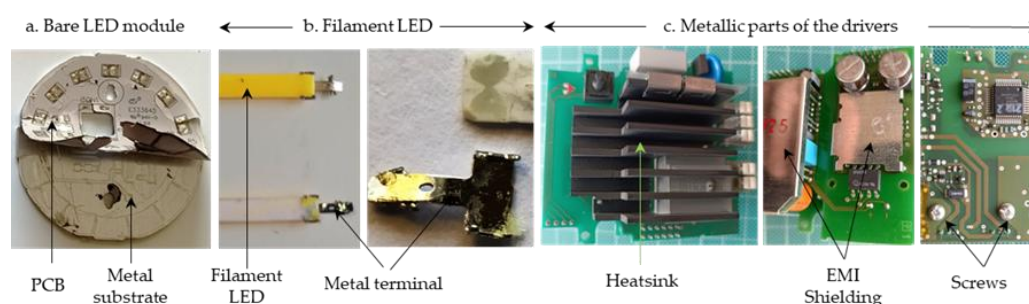


Figure 7. Indicative cases of secondary base metal fractions (authors' images).

2.4. Driver

The design of the driver (Figure A1) and its percentage of the equipment's mass (Figure 8) differed significantly depending on the type and specifications of the equipment. For lamps, using SM-LEDs, the percentage ranged from 2.58 to 25.09 wt%, with the lowest percentage found in the GU10-C type and the highest in the E27-C type. For lamps using filament LEDs, the percentage ranged from 1.16 to 16.07 wt%, with the minimum and maximum percentages found in the same lamp type (E27-R). The driver in LME-A showed an incomparably high percentage (58.74–80.39) wt% compared to all other lighting equipment examined in this study. Finally, in the case of LME-B, the driver's percentage ranged from 16.83 to 32.69 wt%.

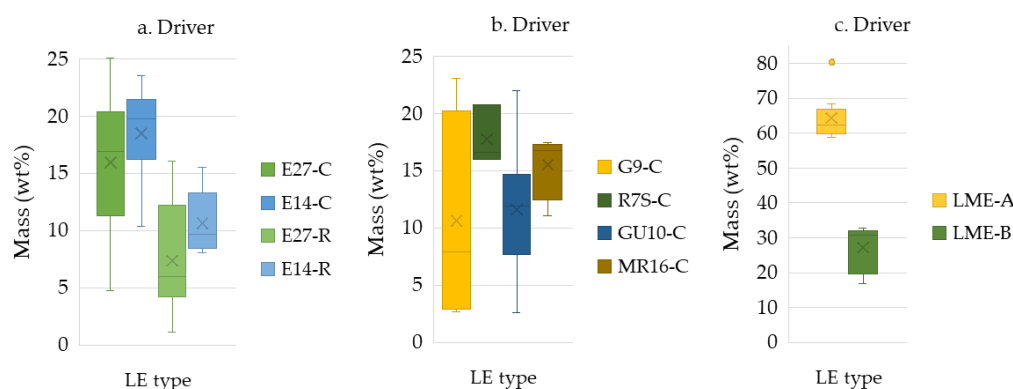


Figure 8. The variation in the mass of the driver relative to the mass of the tested lighting equipment.

The noticeable difference in the percentage of the driver's mass about the lamp's mass, for lamps with the same base type (E27 or E14) but different LED technology (SMD or filament), is due to differences in lamp construction and, in particular, the position of the driver within each lamp. In lamps with SM-LEDs, the driver is located inside the lamp body; in lamps with filament LEDs, it is located inside the lamp base (Figure 9).

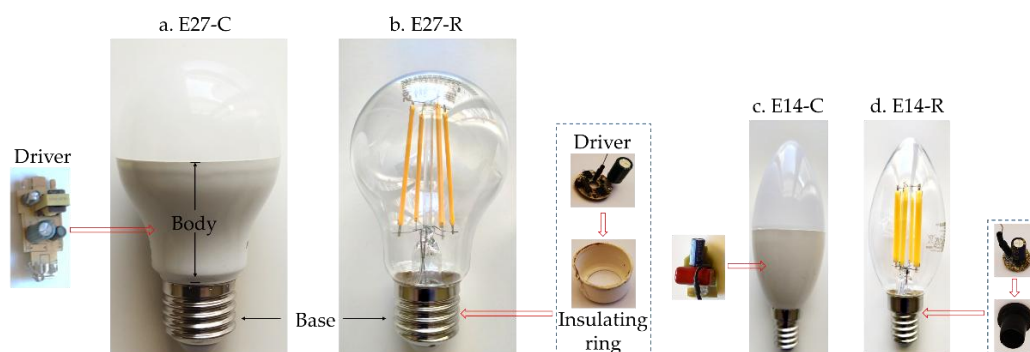


Figure 9. The design and placement of the driver depends on the LED technology used for the lamps (authors' images).

The literature review identified 11 studies concerning the percentage of driver mass in lamps containing SM-LEDs. No studies were identified for lamps containing filament LEDs or for LME cases. The data from the literature review, along with the corresponding results of the present study—particularly, for cases where this was feasible based on sample composition—are presented in Table 1 for quantitative comparison. It is noted that Dzombak et al. (2017) present data on encapsulated driver lamps [80]. In this study, as well as in the few cases of encapsulated drivers, such as those presented in Figure A2, the mass of the encapsulation material ranged from 23.704 to 51.495 g, with an average of 38.499 g. This corresponds to the percentage of encapsulated driver, which ranges from 64.29 to 81.08 wt%, with an average of 71.26 wt%. It is worth noting that, in some cases, the presence of the encapsulation material posed a significant challenge to driver release (Figure A3a), whereas in others, the driver was released without difficulty (Figure A3b) due to the type of encapsulation material.

Table 1. Percentage of drivers in the lighting equipment: A comparison between the literature and the present study.

Literature review						Present study						
LE	BT	ATD	Driver mass			CC	Driver mass			MC		
			Variation	Avg	Ref		Variation	Avg	ATD	I	C	H
Mix		(a)		13	[811]	n/a						
Lamps			8.02		[771]	DA	2.58	15.32	(a)		(x)	
"	E27		5.69	6.1	[821]		4.77	15.93				(x)
"	"			18.84	[831]		"	"			(x)	
"	"			9.36	[841]		"	"				(x)
"	"		12.97	16.71	[851]		"	"		(x)	(x)	
"	"			12	[781]		"	"				(x)
"	"	(b)		13	[861]	n/a						
"	"	(c)		16.02	[871]	DA	4.64	17.02	(b)		(x)	
"	E14	(d)		19	[881]	"	4.77	16.37		(x)		
"	E27	(a)	10.61	28.92	[801]		28.51	47.14			(x)	(x)

(LE) lighting equipment, (BT) base type, (ATD) additional technical details, (CC) corresponding case, (n/a) not available, (DA) data adaption, (MC) mass comparison, (L) lower, (C) comparable, (H) higher. (a) various types of lamps and luminaires. (b) 30 W. (c) same type and brand. (d) E14

2.4.1. Dismantling of Drivers

After manually dismantling the drivers, separating their components resulted in four fractions: other materials (OMs), bare printed circuit board (BPCB), through-hole components (THCs), and surface-mount devices (SMDs). Figure 10, for example, shows the results of dismantling a driver from a GU10-C lamp, which contained no OMs.

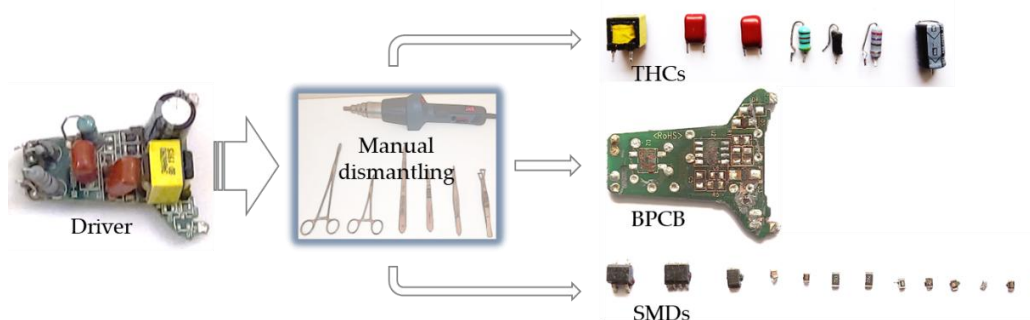


Figure 10. Basic fractions from dismantled drivers (authors' images).

In the case of lamps, OMs consisted mainly of heat-shrinkable materials (HSMs). In contrast, OMs in LME consisted of various components, including heat sinks, electromagnetic interference (EMI) shielding, screws, electrical contacts, and various plastic structures. As shown in Figure 11a, the percentage of OMs varied significantly depending on the equipment, ranging from 0.01 to 59.45 wt%. For lamps in particular, the range was 0.01–15.23 wt%, with an average of 1.88 wt%. For LMEs, the range was 0.14–59.45 wt%, with an average of 14.81 wt%.

As shown in Figure 11b, the percentage of BPCB varied significantly depending on the equipment used, ranging from 0.00 to 74.02 wt%. This finding is consistent with those of Işıldar et al. (2018) [3]. It should be noted that this range also includes lamps with SM-LEDs, where the LED module and driver are integrated into a single structure. For lamps, the BPCB percentage ranged from 0.00 to 71.18 wt%, with an average of 22.24 wt%. This is comparable to Mir and Dhawan's (2022) finding that the average BPCB percentage in the total mass of the driver is 23 wt% [89]. For LME, the BPCB percentage ranged from 13.89 to 74.02 wt%, with an average of 36.51%, which is higher than that found in the aforementioned study.

As shown in Figure 11c, the percentage of THCs varied significantly depending on the equipment, ranging between 0.00–91.13 wt%. In the case of lamps, the range was 0.01–91.13 wt%, with an average of 66.86 wt%. For LME, the range was 4.49–80.15 wt%, with an average of 40.65 wt%. THCs consist of various electrical and electronic components. The presence of each component in the equipment drivers varied significantly depending on the equipment and is presented in Table A1.

As shown in Figure 11d, the percentage of SMDs varied significantly depending on the equipment, ranging from 0.76 to 83.68 wt%. In particular, the percentage of SMDs in lamps ranged from 1.12 to 83.68 wt%, with an average of 9.02 wt%. In the case of LME, the percentage of SMDs ranged from 0.76 to 26.04 wt%, with an average of 8.03 wt%. The SMDs consisted of various electrical and electronic components. The presence of each component in the equipment drivers varied significantly depending on the equipment and is presented in Table A2.

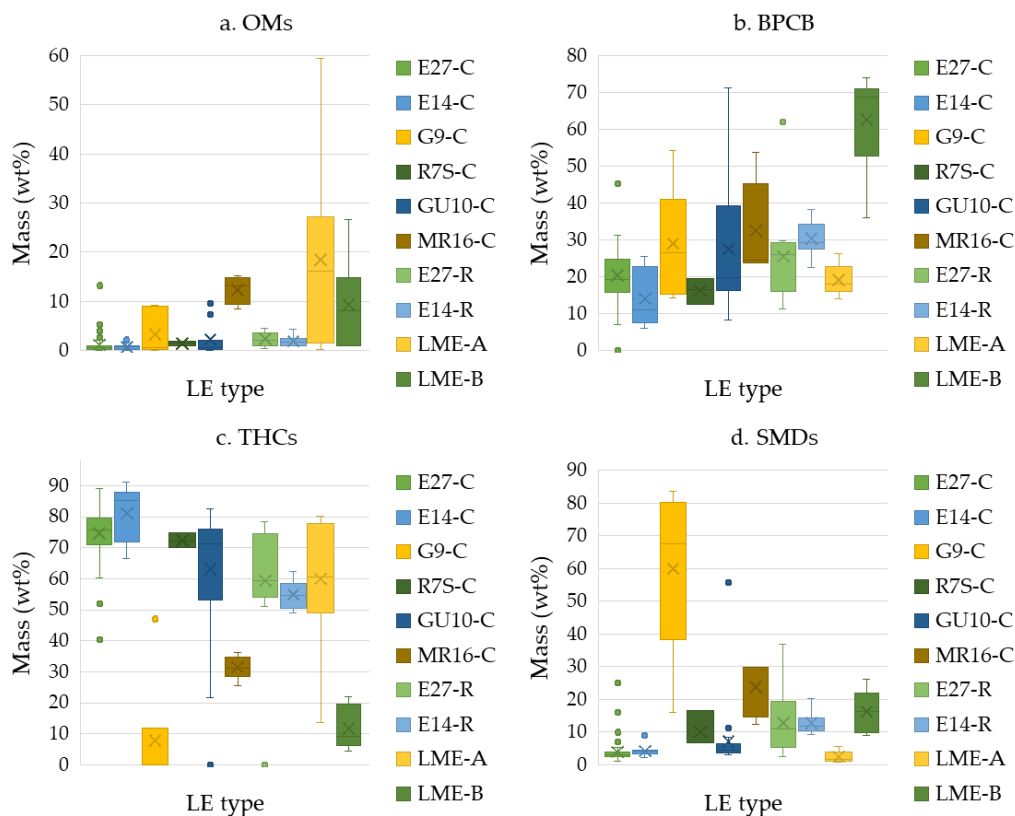


Figure 11. The variation in the mass of the main fractions of the driver from the lighting equipment tested.

2.4.2. Integrated Circuits (ICs)

Through-hole integrated circuits (TH-ICs)

Through-hole integrated circuits (TH-ICs) were only present in LME-A (Figure 12a). Their average mass participation relative to: a) the equipment, ranged from 0.00 to 0.62 wt%, with an average of 0.20 wt%; b) the driver, ranged from 0.00 to 1.03 wt%, with an average of 0.33 wt%; and c) the THCs, ranged from 0.00 to 7.59 wt%, with an average of 1.19 wt%.

Surface mount integrated circuits (SM-ICs)

In contrast to TH-ICs, SM-ICs were present in all types of equipment (Figures 12b and 12c). Depending on the type of lighting equipment, their share of the equipment's mass ranged from 0.04 to 1.90 wt%. The average percentage of the equipment's mass for lamps was 0.09 wt%, ranging from 0.04 to 0.17 wt%. For LME, the average percentage of the equipment's mass was 1.22 wt%, ranging from 0.55 to 1.90 wt%. In particular, and in descending order, their average percentage of the equipment mass was as follows: LME-B (1.90 wt%), LME-A (0.55 wt%), E14-R and MR16-C (0.16 wt%), G9-C (0.10 wt%), E27-C (0.09 wt%), GU10-C and R7S-C (0.07 wt%), E27-R (0.06 wt%), and E14-C (0.04 wt%).

Depending on the type of lighting equipment, the average proportion of SM-ICs in the driver mass ranged from 0.23 to 6.7 wt%. For lamps, the range was (0.23–1.62) wt%, with an average of 0.79 wt%. This is comparable to the percentage reported by Mir and Dhawan (2023) [75] for drivers in general (less than 1 wt%) and to the percentage reported by Li et al. (2019) [76] for drivers in general (more than 1 wt%). For LME, the range was (0.87–6.70) wt%, with an average of 3.79 wt%. This is significantly higher than the corresponding percentages in the aforementioned studies. In descending order of equipment, the average percentage of SM-ICs in the driver mass was as follows: LME-B (6.70 wt%), E14-R (1.62 wt%), MR16-C (0.96 wt%), G9-C (0.94 wt%), E27-R (0.90 wt%), LME-A (0.87 wt%), E27-C and GU10-C (0.63 wt%), R7S-C (0.38 wt%) and E14-C (0.23 wt%).

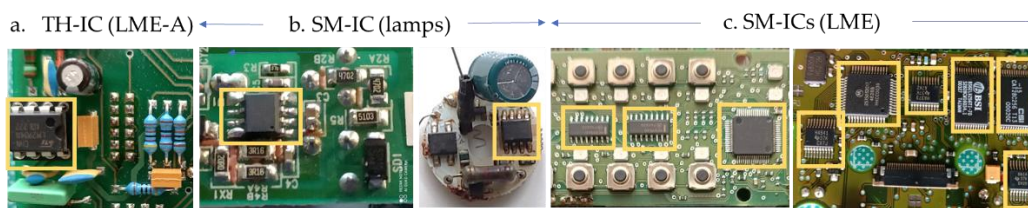


Figure 12. Integrated circuits on the PCBs of lighting equipment were tested. (authors' images).

2.5. Characterisation of ICs from LE via ICP-OES Analysis

ICP-OES analysis of the waste-ICs in this study detected Ag, Au, Pd and Pt. The presence of these metals, either individually or in combination, in waste-ICs is supported by the following studies: Delfini et al. (2011) [49]; Lee et al. (2011) [74]; Jung et al. (2017) [50]; Liu et al. (2018) [55]; Li et al. (2019) [76]; Monneron-Enaud et al. (2020) [39]; Panda et al. (2021) [53]; and Liu Xia et al. (2024) [15]. Additionally, the following studies report on the potential use of the aforementioned precious metals in ICs and microelectronic technology in general. Panda et al. (2020b) report the presence of gold in ICs [90]. Mir and Dhawan (2022) report the presence of Ag and Au in ICs [89]. Silva et al. (2021) report that Ag, Au and Pd are used in IC manufacturing processes as contact or plating materials [36]. An et al. (2023) report the use of platinum (Pt) as a percentage of the wire alloy used in the internal conductive connections of EECs [16]. Marwede et al. (2012) report the potential presence of Ag in the adhesive used for conductive bonding and mechanical support of EECs on PCBs [91].

The presence and concentration of each of the aforementioned PMs in the waste ICs of this study varied significantly depending on the type and origin of the samples. Table 2 presents the results of precious metals concentrations in the waste ICs of this study, along with relevant literature results for comparison. These differences may arise from the origin of the ICs, their specifications, the composition of the adhesive, and the mass of adhesive residue on the pins of the examined ICs. Table 3 in particular shows the concentrations of precious metals detected in the metal fraction (MF) of ICs from computers examined in the study by Panda et al. (2021) [53].

Table 2. Concentration (mg/kg) of precious metals in integrated circuits.

IC type	SO	Ag	Au	Pd	Pt	Ref.
n/a	PC		701	18		[49]
"	Monitor		154	14		[49]
"	TV		315	12		[49]
"	n/a	868	289			[74]
"	"	1494	1365			[74]
"	"	6590	1435			[74]
"	"	1830	1317			[74]
"	"	3410	414			[74]
"	"	353	199			[74]
"	"	471	101			[74]
"	"	1304	490			[74]
"	"	870	407			[74]
"	"	2980	1393			[74]
"	"	2645	1247			[74]
"	"	4188	3386			[74]
"	"	1036	1678			[74]
"	"	656	504			[74]
"	"	617	636			[74]
"	"	2067	1525			[74]
"	"	533	560			[74]
"	"	514	496			[74]
"	"	4325	844			[74]
"	"	1828	1546			[74]
"	"	3167	581			[74]
"	"	2558	1699			[74]
"	Memory	850	1640			[50]
"	n/a	7200				[55]
"	PC	7200				[76]
Small	Medical	211		339		[39]

Ri σ	"	35		1		[39]
n/a	n/a	5200	179			[15]
TH	LME	652	194	OnOI	ND	PS
SM	"	1162	993	49	"	"
"	LED lamps	3876	OnOI	74	OnOI	"

(SO) sample origin, (TH) through-hole, (SM) surface mount, (PC) personal computer,

Table 3. Concentration (mg/kg) of precious metals in metal fraction of integrated circuits.

MF	SO	Ag	Au	Pd	Pt	Ref.
SM-ICs	PC	7480	5880	110	4	[53]

(ME) metal fraction, (SM-ICs) surface mount integrated circuits

2.5.1. Presence per Element

Silver (Ag)

The detection of silver (Ag) in all cases in the present study is consistent with the findings of two previous studies. The first study Lee et al. (2011) examined a large number of different integrated circuits and found continuous Ag presence [74]. The second study Charles et al. (2020) examined ICs from 'large' WEEE and also found Ag in all cases [51].

According to Mir and Dhawan (2022), ICs contain Ag [89], while Silva et al. (2021) state that Ag is used in IC manufacturing processes, specifically as a contact or plating material [36]. Based on the literature, the presence of Ag in waste ICs can potentially be found in the following locations: a) in the wire used for the electrical connection between the die contacts (pads) and the pins of the IC package, in both "multi-layer" [13] and alloy [16] wires; b) in the silver paste used between the die and its substrate [55]; c) in the solder residue [91], as Mori de Oliveira et al. (2022), the adhesive used after the RoHS directive (2006) consists mainly of Ag, Sn and Cu [45].

In this study, the concentration of Ag in waste ICs ranged from 652 to 3876 mg/kg, with an average value of 1897 mg/kg. The lowest concentration was found in TH-ICs from LME, and the highest in SM-ICs from LED lamps. The Ag concentration was found to be: a) significantly lower than the Ag concentration (7480 mg/kg) in the naturally enriched sample (metal fraction of ICs) in the study by Panda et al. (2021) [53]; b) comparable to the values reported in the literature review, which range between 35 and 7200 mg/kg with an average of 2321 mg/kg; and c) incomparably higher than the concentration in the Earth's crust (0.075 mg/kg) [92]. It is worth noting that the potential contribution of adhesive residue to the concentration of Ag in waste ICs also applies to TH-ICs soldered directly to PCB holes. However, there is no such contribution when TH-ICs are placed in the circuit via their special bases.

Gold (Au)

According to Mir and Dhawan (2022), ICs contain gold (Au) [89], while Sheel and Pant (2018) state that the use of gold in ICs contributes to their reliability [54]. Silva et al. (2021) state that Au is used in IC production processes as a contact or plating material [36], while according to Alim et al. (2021) and Sheel & Pant, (2018) gold is found in electrical contacts and internal conductive interconnections between the die pads and the pins of the IC package [13, 54].

The detection of gold in all cases in the present study is consistent with the studies by Delfini et al. (2011) [49], who examined ICs from personal computers, monitors and TVs, and by Lee et al. (2011) [74] and Charles et al. (2020) [51]. Gold was quantified only in LME cases because its concentration in the IC solution from the lamps was lower than the limit of quantification.

The concentration of gold in ICs from the LME ranged from 194 to 993 mg/kg, with an average value of 594 mg/kg. The highest concentration was found in SM-ICs. The gold concentration in the ICs in the present study is: a) significantly lower than the gold concentration (5880 mg/kg) in the naturally enriched IC sample in the Panda et al. (2021) study [53]; b) slightly lower than, or comparable to, the gold concentration in ICs based on literature data which range between 101 and 3386 mg/kg with an average of 959 mg/kg, and c) incomparably higher than the gold concentration in the Earth's crust (0.0032 mg/kg) [92].

Palladium (Pd)

The detection of palladium (Pd) in all cases of integrated circuits (ICs) examined in the present study agrees with studies by Delfini et al. (2011) [49] and Monneron-Enaud et al. (2020) [39]. Additionally, Pd was reported to be present in ICs by Vermeşan et al. (2020) [52], while Charles et al. (2020) [51] reported its occasional presence in the ICs they examined.

Based on the literature, the presence of palladium in ICs has been detected in the wires [13, 16, 93] used for conductive connections between the contacts of the die and the pins of integrated circuit packages, as well as in the coating of the pins [94, 95].

The concentration of palladium in the TH-ICs solution was lower than the quantification limit. Its concentration in SM-ICs ranged from 49 to 74 mg/kg, with an average value of 62 mg/kg, and the highest value was found in SM-ICs collected from lamps. The Pd concentration in SM-ICs in the present study is characterised as follows: a) lower than the Pd concentration in small ICs from medical equipment (339 mg/kg) in the study by Monneron-Enaud et al. (2020) [39]; b) comparable to the Pd concentration (110 mg/kg) in the naturally enriched sample by Panda et al. (2021) [53], c) higher than the Pd concentration in big ICs (1 mg/kg) in the Monneron-Enaud et al. (2020) study [39], d) higher than the Pd concentration (12–18 mg/kg) in ICs examined by Delfini et al. (2011) [49], and finally significantly higher than the Pd concentration in the Earth's crust (0.0082 mg/kg) [92].

Platinum (Pt)

Pt was only detected in lamp SM-ICs, but not quantified as its concentration in the SM-ICs solution did not exceed the quantification limit. The presence of platinum (Pt) in ICs is reported by Vermeşan et al. (2020) [52], while Panda et al. (2021) report a concentration of Pt equal to 4 mg/kg in the naturally enriched sample of their study [53]. For the sake of this study's completeness, platinum is found in microelectronic technology either as platinum foil [96] or as a coating for electrical contacts [97].

We believe that the combination of the commercial value of Pt (€43.15/g) on 18/07/2025 [98], the ever-increasing presence of ICs in EEE due to the widespread use of artificial intelligence [15], and targeted recycling at the component level can create the right conditions for the Granados-Fernández et al. (2021) recommendation for Pt recycling from urban mines [99] to be applied to ICs, despite their negligible Pt content.

2.5.2. Targeted Recycling

Silver concentration in SM-ICs (3876 mg/kg) from LED lamps is much higher than the Ag concentration in E27-C LED lamp drivers (50 mg/kg) and tubes (140 mg/kg), as reported by Cenci et al. (2020) [84]. The outcome of this comparison supports the idea of targeted recycling at the component level, making the effort to recover Ag from ICs particularly worthwhile. In the context of targeted recycling at the component level, Figure 13a presents the variation in Ag concentration in various EECs based on the results of this study and the aforementioned literature. It highlights the low concentration of Ag in integrated circuits (ICs) (35–7200 mg/kg) with an average value of 2280 mg/kg compared to other EECs such as: a) diodes (D) (0–22,800 mg/kg) with an average value of 7774 mg/kg, b) tantalum capacitors (TCs) (2000–68,300 mg/kg) with an average value of 20,102 mg/kg, and c) multi-layer ceramic capacitors (MLCCs) (41–50,100 mg/kg) with an average value of 17,611 mg/kg.

Figure 13b illustrates the variation in gold concentration in ICs (101–3386 mg/kg) with an average value of 933 mg/kg obtained from this study and literature data. This is compared to the gold concentration in other components used in drivers, such as diodes (0–3020 mg/kg) with an average value of 1256 mg/kg, tantalum capacitors –probably TCs with gold plated terminals– (50–60 mg/kg) with an average value of 55 mg/kg, and multi-layer ceramic capacitors with gold plated terminals (10–100 mg/kg) with an average value of 55 mg/kg. Comparing these reveals that the gold concentration in ICs is significantly lower than in diodes, and incomparably higher than in TCs and MLCCs.

Given that the presence of palladium (Pd) in EEE drivers is associated with the presence of MLCCs [100–102], the variation in Pd concentration in integrated circuits (ICs) (1–339 mg/kg) with an average value of 72 mg/kg (combining the results of this study and data from the literature) is incomparably lower than the variation in Pd concentration in TCs –probably wet tantalum

capacitors– and MLCCs (Figure 13c). According to the aforementioned literature, the variation in Pd concentration in MLCCs ranges from 21 to 16,808 mg/kg with an average value of 6190 mg/kg.

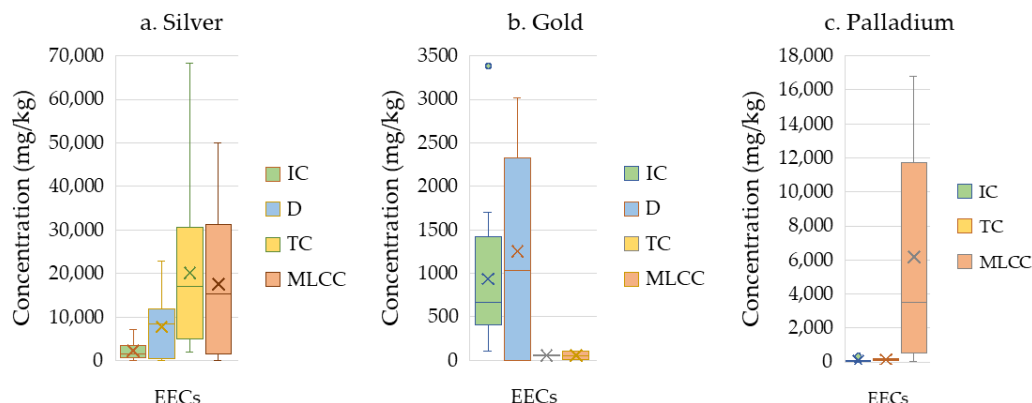


Figure 13. Variation in the concentration of precious metals in integrated circuits compared to other driver components.

2.5.3. The Presence and Stored Value of PMs in ICs

Figure 14a shows the stored potential of PMs (mg/kg) in the ICs examined in this study, highlighting the significant variation depending on the type and origin of the ICs: TH-ICs (846.017 mg/kg), SM-ICs from LME (2203.870 mg/kg) and SM-ICs from LED lamps (3949.608 mg/kg). The percentage of each element in the stored potential of the PMs varied significantly depending on the type and origin of the ICs examined. Specifically: a) in the case of TH-ICs: Ag (77.09 wt%) and Au (22.91 wt%); b) SM-ICs from the LME: Ag (52.73 wt%), Au (45.07 wt%) and Pd (2.21 wt%); and c) SM-ICs from LED lamps: Ag (98.13 wt%) and Pd (1.87 wt%).

Despite the apparent predominance of precious metals in lamp ICs, the economic value stored in waste ICs in each application case was essentially determined by the presence of gold (Figure 14b). This was due to its high price (102.77 €/g on 18 July 2025), compared to silver (1.23 €/g) and palladium (39.65 €/g), as well as the low proportion of palladium.

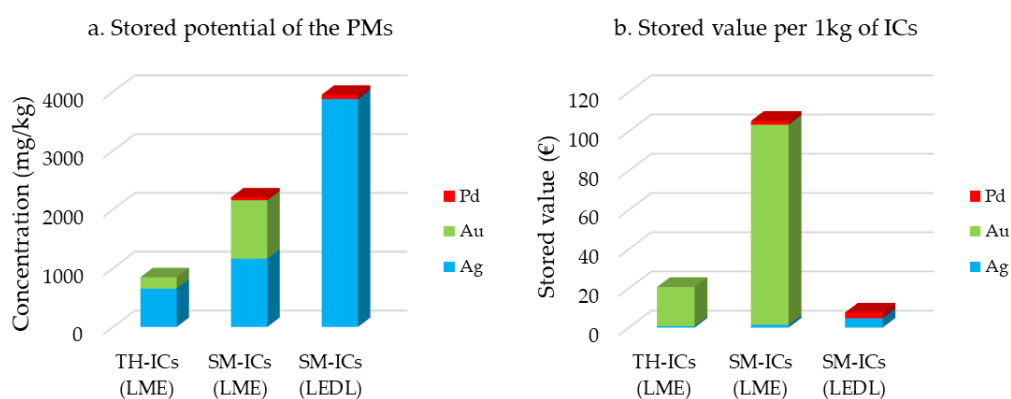


Figure 14. The stored potential of precious metals in the examined integrated circuits (a), and the stored value due to the presence of these precious metals in the examined integrated circuits.

The stored economic value in euros per 1 kg of ICs, highlighting the superiority of SM-ICs from the LME (105.43 €/kg), followed by TH-ICs (20.72 €/kg) and SM-ICs from LED lamps (7.69 €/kg). The percentage contribution of each metal to the stored economic value in each application case was as follows: a) TH-ICs (LME): Ag (3.87%) and Au (96.13%); b) SM-ICs (LME): Ag (1.36%), Au (96.82%) and Pd (1.83%); and c) SM-ICs (LED lamps): Ag (61.99%) and Pd (38%).

Considering that the degree of gold recovery from ICs ranges between 90 and 100% [75], the percentage of gold in stored economic value in ICs presents an increase of approximately 16% on the

percentage of gold in the recovered economic value from equipment drivers reported by D. Xia et al. (2024) [38]. This increase could be explained by targeted recycling at the component level as opposed to targeted recycling at the individual structure level of WEEE.

2.5.4. The Stored Potential of PMs in EEE

Taking into account the following parameters: a) the concentrations (mg/kg) of Ag, Au and Pd in the integrated circuits of this study; b) the percentage contribution (wt%) of each lamp in the random sample; and c) the average percentage contribution (wt%) of ICs in lighting equipment, the contribution of each type of lighting equipment (LED lamps, LME-A and LME-B) to the stored potential of precious metals in each application case is calculated (Figure 15). Figure 15a illustrates the contribution of each lamp type to the stored potential of Ag and Pd. It highlights the clear superiority of E27-C lamps, which account for 59.07 wt% of the total, followed by GU10-C lamps, which account for 18.98 wt%. The contribution of the other lamp types was low, ranging from 2.14 to 5.70 wt%. Figure 15b illustrates the contribution of each type of integrated circuit (TH-ICs and SM-ICs) to the stored potential of precious metals (Ag, Au and Pd) in LME-A. It highlights the clear superiority of SM-ICs in Ag and Au due to their higher presence (wt%) in LME-A and higher concentrations (mg/kg) in integrated circuits. Notably, Au is present in significant quantities (5.855 g), in contrast to its complete absence in lamps. Finally, Figure 15c illustrates the tripling of the stored potential of PMs in LME-B compared to LME-A. This significant increase is due to the higher percentage of SM-ICs in LME-B, which creates a substantial stored value in the ICs of the equipment solely due to the presence of gold (Au), equivalent to €1,939 per tonne of equipment.

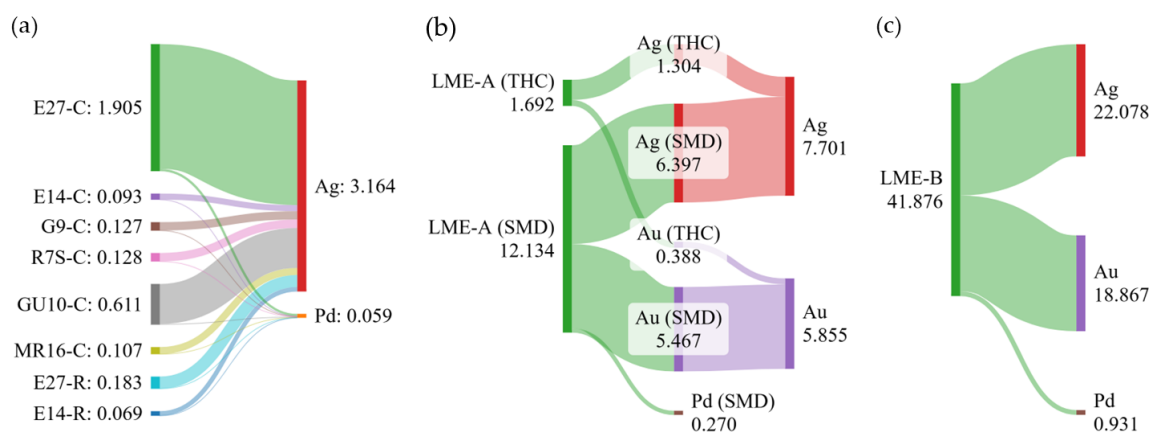


Figure 15. Distribution of average stored potential (g) of precious metals—due to the presence of integrated circuits—in the lighting equipment examined (made at SankeyMatic.com).

3. Materials and Methods

The lighting equipment (LE) used in this study consisted of: a) a random sample of 10.017 kg of LED lamps for domestic lighting applications (consisting of 219 pieces) provided by Aegean Recycling-Foundries SA; and b) building energy management equipment (specifically, natural and artificial lighting management equipment capable of supporting the operational needs of a modern 240 m² residence) provided by Siemens Greece and ABB Greece. According to Sideris et al. (2023) [19] estimated that the lamps were produced between 2016 and 2021, whereas the LME sponsors stated that they were produced between 2012 and 2020. The experimental process included the following stages, from equipment collection to integrated circuit characterisation. These stages are summarised in the step-by-step flow chart in Figure A4.

3.1. Collection and Separation

The first stage included the following: collection, cleaning, macroscopic integrity check, separation, selection of unique lamps and units of LME in terms of electrical characteristics, Weighing

using Balance (brand: KERN, model: EHA 1000-1, precision: 0.1 g), and Precision balance (brand: KERN, model: EWJ-300-3, precision: 0.001 g)

3.2. Collection and Separation

Unique units were selected for investigation from the initial random sample of LE. These differed in either their technical characteristics or brand name (BN).

3.3. Dismantling and Separation

The second stage included: a) manually dismantling the equipment into its basic components (mainly the body, LED module, filament LEDs and driver) using basic tools such as screwdrivers and cutters; b) grouping the basic materials (metals, plastics, glass, ceramics, etc.) and functional units (LED modules, filament LEDs, drivers, etc.); c) completely dismantling the drivers using special tools such as a magnifying glass, tweezers and a hot air gun with a temperature rating (brand: BOSCH (Robert Bosch GmbH, Stuttgart, Germany), model: GHG 20-60), and the necessary personal protective equipment (gloves, protective goggles and an activated carbon mask); d) Identification and separation of indistinguishable EECs in the drivers using a magnifying glass and a digital instrument to identify surface-mount device components (brand: Mastech, model: MS8910); and e) Weighing all of the above mass fractions of the equipment using a precision balance (brand: KERN (KERN & SOHN GmbH, Balingen, Germany), model EWJ-300-3, precision: 0.001 g.

3.4. Preparing Porcelain Crucibles and Calcination of ICs

The calcination temperature of the plastic ICs was selected, and the porcelain crucibles were prepared based on the thermogravimetric analysis (TGA) results of an IC (Figure 16a), performed with a thermogravimetric analyser (brand: Setaram (Setaram Research Services, Geneva, Switzerland), Model: TG DTA DSC +1600°C. A temperature of 700°C was selected. The porcelain crucibles (brand: JIPO (Jizerská porcelánka s.r.o., Desná v Jizerských horách I, Czech Republic) with a middle form), were prepared including cleaning, initial weighing, heating, natural cooling in a desiccator according to the heating-cooling profile shown in Figure 16b, final weighing, and careful storage.

Before calcination (Figure 16c), the plastic ICs were lightly broken in an agate mortar to achieve more efficient combustion of their encapsulation material [55] and optimal release of their sub-structures [74] (die, solder wires and pins) during pulverisation. According to Nieberl et al. (2023), thermal methods can increase the energy consumption of the aforementioned experimental process. However, they can also achieve the good decomposition of epoxy resin and other plastic encapsulation materials used in the electronics industry. This contributes to releasing the IC internal structure for recycling [8]. The above laboratory steps were carried out using: a) an analytical balance (brand: KERN (KERN & SOHN GmbH, Balingen, Germany), model: ABP 200-4M, precision: 0.0001 g) and a laboratory furnace (brand: THERMOLYNE (THERMOLYNE – ThermoFisher Scientific, Waltham, USA), model: 30400).

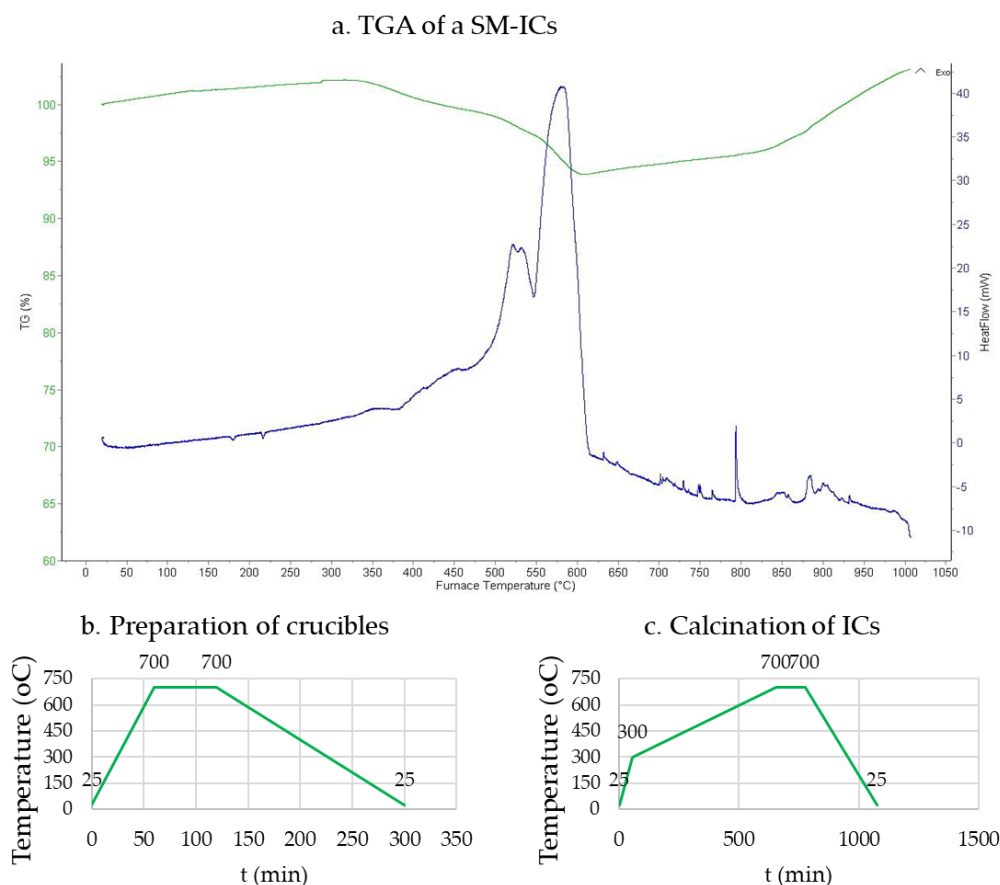


Figure 16. (a) Thermogravimetric analysis of a plastic SM-ICs, and temperature and time profiles for crucible preparation (b) and ICs calcination (c).

3.5. Creation of Laboratory Samples

After calcination of the plastic ICs for the creation of laboratory samples and to maximise the effectiveness of the acids (HNO_3 and aqua regia) on them [72, 73, 103], they were pulverised using a ball mill (Brand: FRITSCH, model Pulverisette 6), with a zirconium oxide planetary ball mill tank (FRITSCH, volume 80 ml). Then, after quartering, a mass of ~1 g per sample was selected using an analytical balance (brand: SHIMADZU; model: AUX320; precision: 0.0001).

3.6. Dissolution of Samples

Taking into account the studies by Zamprogno, Rebello et al. (2020) [81] and Wu et al. (2022) [40], the samples were dissolved in HNO_3 and aqua regia. The samples were placed in glass beakers with a solid-to-liquid ratio of 1:40 on a thermostatic heating plate at 90–100 °C and stirred manually until complete dissolution (~3 hours). The following additional parameters were taken into account: a) Ag determination is recommended in HNO_3 to avoid the formation of silver chloride (AgCl) [84], b) Au and Pt can only be dissolved in aqua regia and c) Pd can be dissolved in aqua regia and concentrated HNO_3 [104]. All processes were carried out in a fume hood, with all appropriate measures taken to protect humans and the environment. The concentrated acids (HNO_3 65%; HCl 35–38%) used either directly or for preparing fresh aqua regia (HCl : HNO_3 ratio 3:1) were all analytical grade (brand MACRON, Avantor, Pennsylvania, USA) and supplied by Chemix SA.

3.7. ICP-OES Analysis

To determine the precious metals (Ag, Au, Pd and Pt) in the solution, the ICP-OES instrument (brand: Agilent; model: 5110) was first calibrated using five aqueous standard solutions: 0.5, 2, 4, 10 and 20 mg/L, as well as calibration standards for Ag (brand: HPS, name: ICP-AM-MISA6 – 27 components) and the PMs (brand: CPA Hem, name: MISA Standard 2 – Precious Metals – 6

components). To protect the instrument, the initial solutions were filtered using filter paper (brand: Ahlstrom-Munksjö; type: hardened low-ash; grade: 391) and ultrapure water (brand: PanReac; type: LC-MS) until the solution volume reached 100 ml. The operating parameters of the instrument were the same for both acids: a) Radio frequency (RF) power: 1300 W, b) Auxiliary gas flow: 0.2 L/min, c) Nebulisation gas flow: 0.8 L/min, d) Plasma gas flow: 15 L/min, e) Torch configuration: Axial, f) Sample aspiration rate: 1.5 L/min

4. Conclusions

Given that the number and type of ICs in EEE drivers, as well as the presence of precious metals in their structure, depend on the type of equipment, its specifications, and its date of manufacture, this study investigated the concentrations of precious metals (Ag, Au, Pd, and Pt) in waste ICs removed from drivers of equipment that contributes to energy saving and maintaining comfortable conditions in buildings, such as LED lamps and LME.

The integrated circuits were removed from the lighting equipment and separated based on their origin (lamps, LME-A or LME-B) and the type of IC installation in the equipment drivers (through-hole or surface-mount). The presence of ICs in the equipment varied significantly depending on the equipment's subcategory. In particular, the presence of TH-ICs ranged from 0.00 to 0.62 wt%, while the presence of SM-ICs ranged from 0.04 to 1.90 wt%.

The concentrations of precious metals in integrated circuits varied significantly depending on the type and origin of the samples. In particular, the concentrations of Ag, Au, Pd, and Pt were found to be (652–3876) mg/kg, (0–993) mg/kg, (0–74) mg/kg, and not quantified (due to concentrations below the quantification limit), respectively. These concentrations create significant stored value in the examined ICs, ranging from €7.69 to €105.43 per kilogram. The contribution of each precious metal to this value is as follows: Ag: 1.36–61.99%, Au: 96.15–96.82%, and Pd: 1.83–38.00%.

The average stored potential of PMs in a 1 t assumed mass of lighting equipment, calculated as a function of the aforementioned PM concentrations, ranged from 3.164 to 22.078 g/t for Ag, from 0 to 18,867 g/t for Au, and from 0.059 to 0.931 g/t for Pd.

The findings of this study provide an incentive to eliminate the phenomenon of WEEE remaining in buildings and to transfer it to urban mines. Unlike natural deposits in the Earth's crust, urban mines offer an extensive and concentrated number of chemical elements in a limited space. Furthermore, unlike natural mining, which has a high environmental impact and irreversibly depletes natural reserves, recovering high-value metals from urban mines protects the environment and natural resources and reduces the cost of recovering low-value critical raw materials from WEEE.

In addition, the results of this study support the need for the separation and dismantling of waste electrical and electronic equipment (WEEE) during the pre-treatment phase, as well as targeted recycling at the component level. This will further contribute to the recovery of specific metals from waste electrical and electronic components.

Author Contributions: Conceptualization, K.M.S. and P.S.; methodology, K.M.S., D.F. and V.N.S.; validation, K.A.L., V.N.S. and D.F.; formal analysis, K.M.S.; investigation, K.M.S.; resources, D.F. and V.N.S.; data curation, K.M.S. writing—original draft preparation, K.M.S. writing—review and editing, P.S., K.A.L., D.F. and V.N.S.; visualization, K.M.S.; supervision, P.S. and V.N.S.; project administration, P.S. All authors have read and agreed to the published version of the manuscript.

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Conflicts of Interest: The authors declare that they have no known competing financial interest or personal relationships that could have influenced the work reported in this study.

Abbreviations

The following abbreviations are used in this manuscript:

ADT	Additional technical details
BPCBs	Bare printed circuit boards
BT	Base type
CC	Corresponding case
D	Diodes
DA	Data adaption
EECs	Electrical and electronic components
EEE	Electrical and electronic equipment
EIMs	Electrical insulation materials
EU	European Union
ICs	Integrated circuits
LE	Lighting equipment
LED	Light-emitting diode
LEDL	Light-emitting diode lamps
LME	Lighting management equipment
MC	Mass comparison
MF	Metal fraction
MLCCs	Multi-layer ceramic capacitors
n/a	Not available
ND	Not detected
OMs	Other materials
OoQL	Out of quantification limit
PC	Personal computer
PCB	Printed circuit board
PMs	Precious metals
PS	Present study
SM	Surface mount
SMD	Surface mount devices
SM-LEDs	Surface mount light-emitting diodes
SM-ICs	Surface mount integrated circuits
SO	Sample origin
TCs	Tantalum capacitors
TH	Trough-hole
THCs	Through-hole components
TH-ICs	Through-hole integrated circuits
WEEE	Waste electrical and electronic equipment

Appendix A

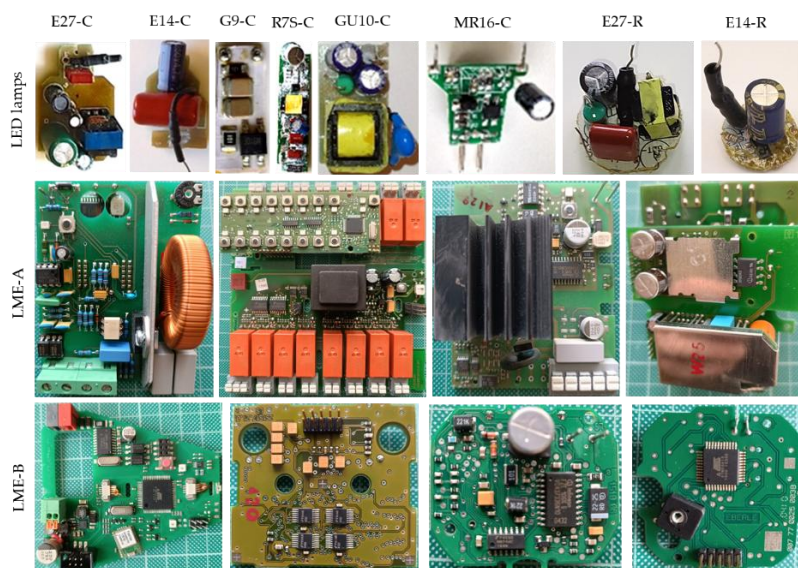


Figure A1. Lighting equipment drivers. Their design varies depending on the application. (authors' images).

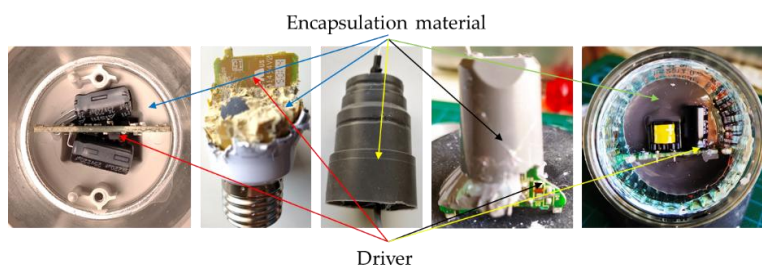


Figure A2. Examples of encapsulated drivers found in the examined lighting equipment (authors' images).

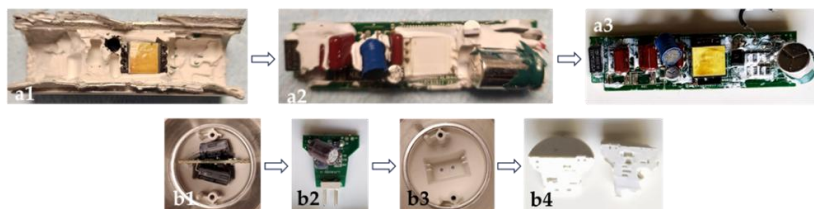


Figure A3. Challenges (a) and non-challenges (b) encountered during the release of the lighting equipment's encapsulated driver (authors' images).

Table 1. Presence of through-hole components in the drivers of the lighting equipment examined.

THC	E27-C	E14-C	G9-C	R7S-C	GU10-C	MR16-C	E27-R	E14-R	LME-A	LME-B
TF	(x)	(x)		(x)	(x)		(x)		(x)	
Coil	(x)	(x)		(x)	(x)		(x)		(x)	
AEC	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)
MPFC	(x)	(x)	(x)	(x)	(x)		(x)			
CC									(x)	
TRs				(x)						
RES	(x)	(x)	(x)	(x)	(x)		(x)	(x)	(x)	
FWBR			(x)						(x)	
RoCs	(x)									

CON N		(x)			(x)	(x)			(x)	(x)
Relay									(x)	
TB									(x)	
Butto n									(x)	(x)
PFC									(x)	
P-TR									(x)	
Varist or									(x)	
Diode									(x)	
IC									(x)	

Abbreviations: (TF) transformer, (AEC) aluminium electrolytic capacitor, (MPFC) metallized polyester film capacitor, (CC) ceramic capacitor, (TR) transistor, (RES) Resistor, (FWBR) full wave bridge rectifier, (RoCs) rest of components, (CONN) connector, (TB) terminal block, (PFC)

Table 2. Presence of surface mount devices in the drivers of the lighting equipment examined.

SMD	E27-C	E14-C	G9-C	R7S-C	GU10-	MR16	E27-R	E14-R	LME-	LME-
IC	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)
FWBR	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)
Resisto	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)
Diode	(x)	(x)		(x)	(x)	(x)	(x)	(x)	(x)	(x)
TR	(x)	(x)	(x)	(x)	(x)		(x)	(x)	(x)	(x)
Induct				(x)		(x)			(x)	(x)
MLCC	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)	(x)
TC									(x)	(x)
Z-									(x)	(x)
LED									(x)	(x)
Button									(x)	(x)

Abbreviations: (IC) integrated circuit, (FWBR) full wave bridge rectifier, (TR) transistors, (MLCC) multi-layers ceramic capacitor, (TC) tantalum capacitor, (Z-diode) Zener diode, (LED) light

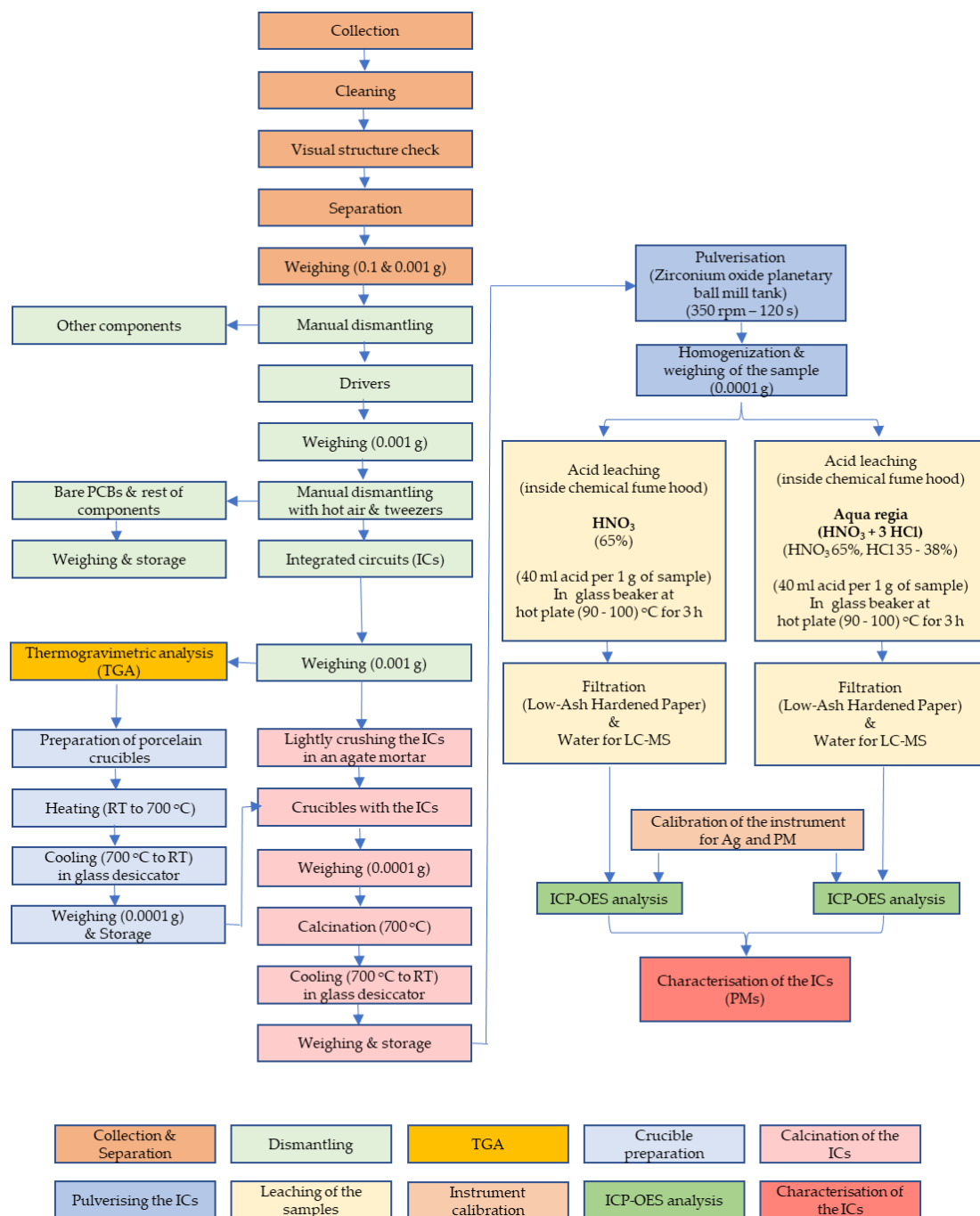


Figure A4. Experimental flow chart from the collection of lighting equipment to the characterization of ICs.

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